MOSFET – Power, Single, N-Channel, μ8FL 30 V, 44 A

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- DC–DC Converters
- Power Load Switch
- Notebook Battery Management

MAXIMUM RATINGS (T_J = 25° C unless otherwise stated)

Paran	Symbol	Value	Unit		
Drain-to-Source Voltage			V _{DSS}	30	V
Gate-to-Source Voltage			V _{GS}	±20	V
Continuous Drain		$T_A = 25^{\circ}C$	I _D	13.3	А
Current $R_{\theta JA}$ (Note 1)		T _A = 80°C		9.9	
Power Dissipation $R_{\theta JA}$ (Note 1)		$T_A = 25^{\circ}C$	P _D	2.09	W
Continuous Drain		T _A = 25°C	I _D	18.2	А
Current $R_{\theta JA} \le 10 \text{ s}$ (Note 1)		T _A = 80°C		13.6	
Power Dissipation $R_{\theta JA} \leq 10 \text{ s} \text{ (Note 1)}$	Steady	T _A = 25°C	P _D	3.9	W
Continuous Drain	State	T _A = 25°C	I _D	8.2	А
Current $R_{\theta JA}$ (Note 2)		T _A = 80°C		6.1	
Power Dissipation $R_{\theta JA}$ (Note 2)		$T_A = 25^{\circ}C$	PD	0.79	W
Continuous Drain		$T_{C} = 25^{\circ}C$	I _D	44	А
Current R _{θJC} (Note 1)		$T_{\rm C} = 80^{\circ}{\rm C}$		33	
Power Dissipation $R_{\theta JC}$ (Note 1)		T _C = 25°C	PD	23.6	W
Pulsed Drain Current	T _A = 25°0	T _A = 25°C, t _p = 10 μs		128	А
Operating Junction and S	Т _Ј , T _{stg}	–55 to +150	°C		
Source Current (Body Diode)			ا _S	20	А
Drain to Source dV/dt			dV/dt	6.0	V/ns
Single Pulse Drain-to-Source Avalanche Energy $(T_J = 25^{\circ}C, V_{DD} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_L = 25 \text{ A}_{pk}, L = 0.1 \text{ mH}, R_G = 25 \Omega)$ (Note 3)			E _{AS}	31	mJ
Lead Temperature for So (1/8" from case for 10 s)	Idering Pur	poses	ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

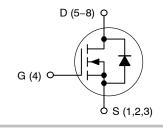


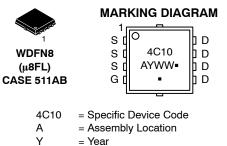
ON Semiconductor®

www.onsemi.com

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
30 V	7.4 mΩ @ 10 V	44 A
50 V	11 mΩ @ 4.5 V	77 A







(Note: Microdot may be in either location)

= Work Week = Pb-Free Package

WW

ORDERING INFORMATION

Device	Package	Shipping [†]				
NTTFS4C10NTAG	WDFN8 (Pb-Free)	1500 / Tape & Reel				
NTTFS4C10NTWG	WDFN8 (Pb-Free)	5000 / Tape & Reel				

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

- 2. Surface-mounted on FR4 board using the minimum recommended pad size.
- 3. This is the absolute maximum ratings. Parts are 100% tested at $T_J = 25^{\circ}$ C, $V_{GS} = 10 \text{ V}$, $I_L = 17 \text{ A}$, $E_{AS} = 14 \text{ mJ}$.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ ext{ heta}JC}$	5.3	
Junction-to-Ambient - Steady State (Note 4)	R_{\thetaJA}	59.9	°C 444
Junction-to-Ambient - Steady State (Note 5)	R_{\thetaJA}	157.8	°C/W
Junction-to-Ambient – (t \leq 10 s) (Note 4)	R_{\thetaJA}	31.8	

4. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

5. Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Cond	ition	Min	Тур	Max	Unit
OFF CHARACTERISTICS					-	-	-
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D =	= 250 μA	30			V
Drain-to-Source Breakdown Voltage (transient)	V _{(BR)DSSt}	V_{GS} = 0 V, $I_{D(aval)}$ = 7.1 A, T _{case} = 25°C, t _{transient} = 100 ns		34			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				14.5		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V$, $T_J = 25^{\circ}C$				1.0	
		$V_{DS} = 24 V$	T _J = 125°C			10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	_S = ±20 V			±100	nA
ON CHARACTERISTICS (Note 6)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 250 \ \mu A$		1.3		2.2	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				4.5		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 30 A		5.9	7.4	mΩ
		V _{GS} = 4.5 V	I _D = 15 A		8.8	11	
Forward Transconductance	9 _{FS}	V _{DS} = 1.5 V, I	_D = 15 A		43		S
Gate Resistance	R _G	T _A = 25	٥c		1.0		Ω
CHARGES AND CAPACITANCES							
Input Capacitance	C _{ISS}				993		
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 MH	lz, V _{DS} = 15 V		574		pF
Reverse Transfer Capacitance	C _{RSS}				163		1
Capacitance Ratio	C _{RSS} /C _{ISS}	V _{GS} = 0 V, V _{DS} = 15 V, f = 1 MHz			0.164		
Total Gate Charge	Q _{G(TOT)}				9.7		
Threshold Gate Charge	Q _{G(TH)}				1.5		1
Gate-to-Source Charge	Q _{GS}	V _{GS} = 4.5 V, V _{DS} =	15 V; I _D = 30 A		2.8		nC
Gate-to-Drain Charge	Q _{GD}				4.8		1
Gate Plateau Voltage	V _{GP}				3.2		V
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 1	15 V; I _D = 30 A		18.6		nC

SWITCHING CHARACTERISTICS (Note 7)

6. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.

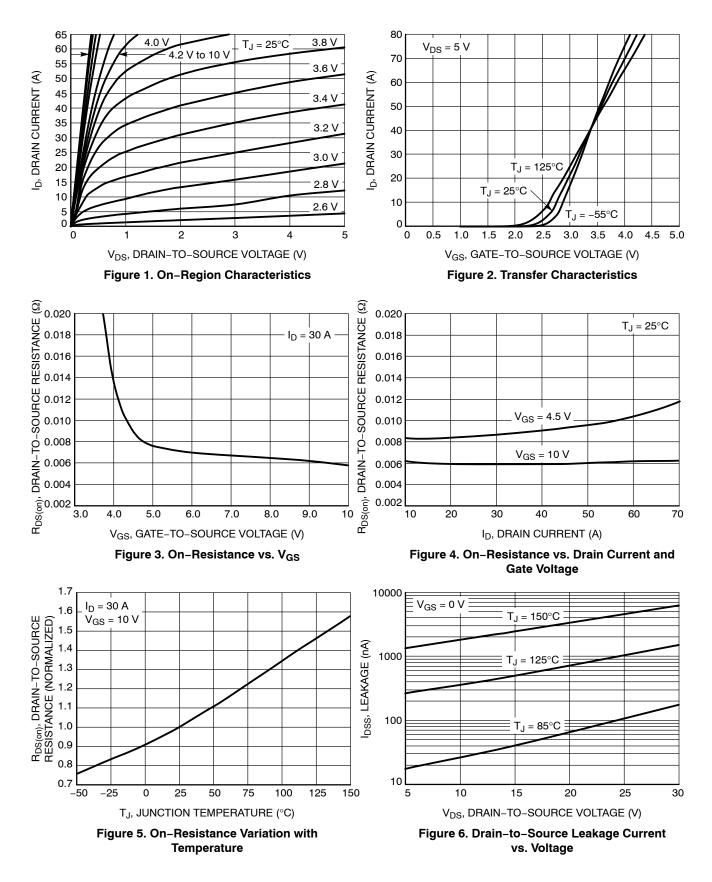
7. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

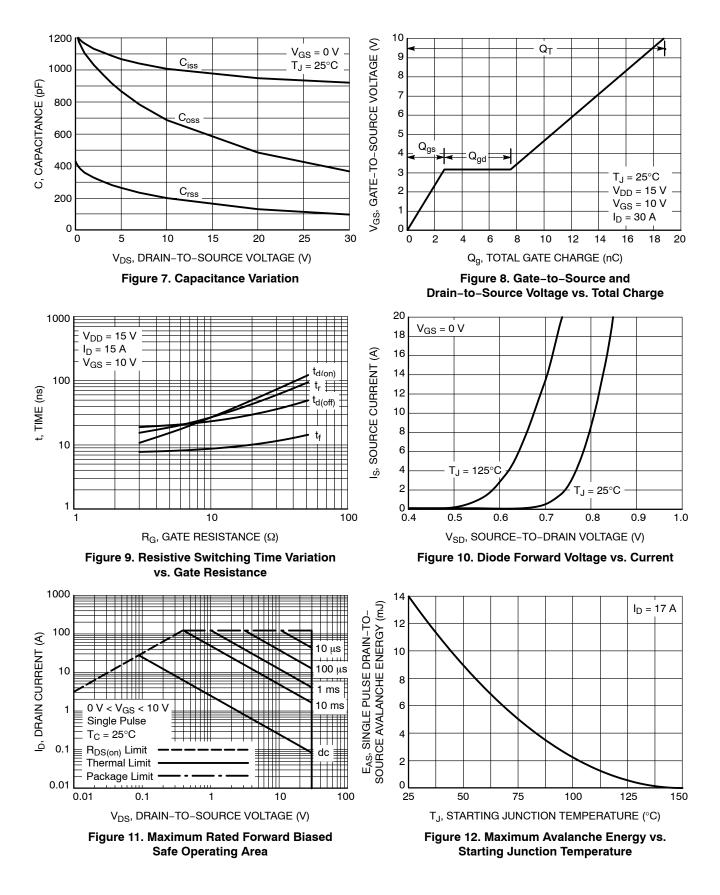
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	lote 7)	•					
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 4.5 V, V_{DS} = 15 V, I _D = 15 A, R _G = 3.0 Ω			9.0		ns
Rise Time	t _r				30		
Turn-Off Delay Time	t _{d(OFF)}				14		
Fall Time	t _f				7.0		
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 10 V, V_{DS} = 15 V, I _D = 15 A, R _G = 3.0 Ω			6.0		ns
Rise Time	t _r				25		
Turn-Off Delay Time	t _{d(OFF)}				18		
Fall Time	t _f				4.0		
DRAIN-SOURCE DIODE CHARACT	ERISTICS						
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 V, \\ I_{S} = 10 A \\ T_{J} = 25^{\circ}C \\ T_{J} = 125^{\circ}C$			0.80	1.1	V
					0.67		v
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dIS/dt = 100 A/µs, I _S = 30 A			23.3		
Charge Time	t _a				12.7		ns
Discharge Time	t _b				10.6		
Reverse Recovery Charge	Q _{RR}				8.3		nC

 $\begin{array}{ll} \mbox{6. Pulse Test: pulse width } \le 300 \ \mu \mbox{s, duty cycle } \le 2\%. \\ \mbox{7. Switching characteristics are independent of operating junction temperatures.} \end{array}$

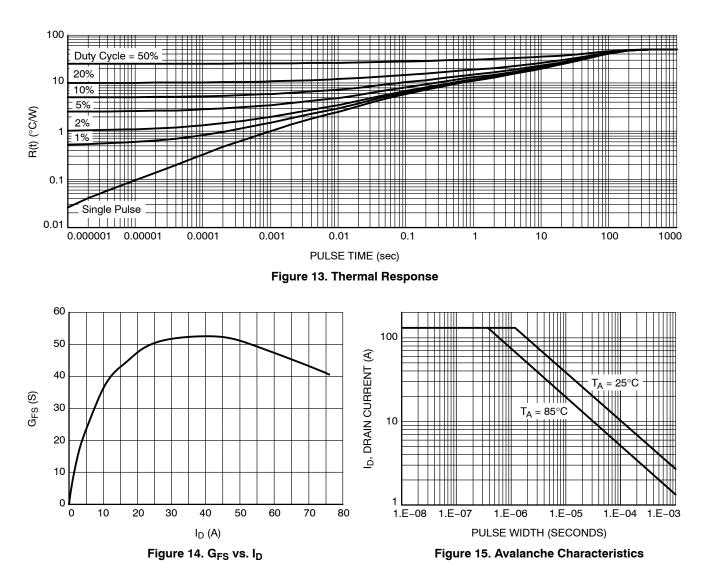
TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



DATE 23 APR 2012





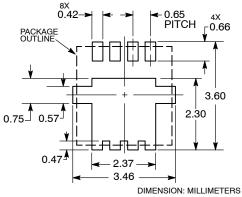
Pb-Free indicator, "G" or microdot " .", may or may not be present.

NOTES: LES: DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS. DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS. 1.

2. 3.

	м	LLIMETE	RS		INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.70	0.75	0.80	0.028	0.030	0.031	
A1	0.00		0.05	0.000		0.002	
b	0.23	0.30	0.40	0.009	0.012	0.016	
с	0.15	0.20	0.25	0.006	0.008	0.010	
D		3.30 BSC		0.130 BSC			
D1	2.95	3.05	3.15	0.116 0.120		0.124	
D2	1.98	2.11	2.24	0.078	0.083	0.088	
E	3.30 BSC			0.130 BSC			
E1	2.95	3.05	3.15	0.116	0.120	0.124	
E2	1.47	1.60	1.73	0.058	0.063	0.068	
E3	0.23	0.30	0.40	0.009	0.012	0.016	
е	0.65 BSC			0.026 BSC			
G	0.30	0.41	0.51	0.012	0.016	0.020	
к	0.65	0.80	0.95	0.026	0.032	0.037	
L	0.30	0.43	0.56	0.012	0.017	0.022	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
м	1.40	1.50	1.60	0.055	0.059	0.063	
θ	0 °		12 °	0 °		12 °	

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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